



## **SPECIFICATION**

• Supplier : Samsung electro-mechanics • Samsung P/N : CL21A476MQ9LRNC

• Product : Multi-layer Ceramic Capacitor • Description : CAP, 47 µF, ±20%, 6.3V, X5R, 0805

## A. Samsung Part Number

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1	Series	Samsung Multi-layer Ceramic Capacitor		
2	Size	0805 (inch code)	L: 2.0 ± 0.2 mm W: 1.25 ± 0.2 mm	
			Thickness division Low profile	
3	Dielectric	X5R	Inner electrode Ni	
4	Capacitance	<b>47</b> μF	Termination Cu	
(5)	Capacitance	±20 %	Plating Sn 100% (Pb Free)	
	tolerance		Product L,W size tolerance change co	de
6	Rated Voltage	6.3 V	Special Reserved for future use	
7	Thickness	0.9 ± 0.1 mm	(f) Packaging Cardboard Type,7"reel(4,000e	ea)

## **B. Samsung Reliability Test and Judgement condition**

	Performance	Test condition			
Capacitance	Within specified tolerance	120Hz ±20% 0.5±0.1Vrms			
Tan δ (DF)	0.1 max.				
Insulation	More than 50Mohm⋅μF	Rated Voltage 60~120 sec.			
Resistance					
Appearance	No abnormal exterior appearance	Visual inspection			
Withstanding	No dielectric breakdown or	250% of the rated voltage			
Voltage	mechanical breakdown				
Temperature	X5R				
Characteristics	(From -55℃ to 85℃, Capacitance change should be within ±15%)				
Adhesive Strength	No peeling shall be occur on the	500g·F, for 10±1 sec.			
of Termination	terminal electrode				
Bending Strength	Capacitance change : within ±12.5%	Bending to the limit (1mm)			
		with 1.0mm/sec.			
Solderability	More than 75% of terminal surface	SnAg3.0Cu0.5 solder			
	is to be soldered newly	245±5°C, 3±0.3sec.			
		(preheating : 80~120 ℃ for 10~30sec.)			
Resistance to	Capacitance change: within ±7.5%	Solder pot : 270±5 ℃, 10±1sec.			
Soldering heat	Tan δ, IR : initial spec.				

	Performance	Test condition
Vibration Test	Capacitance change : within ±5%	Amplitude : 1.5mm
	Tan δ, IR : initial spec.	From 10Hz to 55Hz (return : 1min.)
		2hours × 3 direction (x, y, z)
Moisture	Capacitance change: within ±12.5%	With rated voltage
Resistance	Tan δ : 0.25 max	40±2℃, 90~95%RH, 500 +12/-0 hours
	IR : More than 8.9MΩ· <i>μ</i> F	
High Temperature	Capacitance change: within ±12.5%	With 100% of the rated voltage
Resistance	Tan δ : 0.25 max	Max. operating temperature
	IR ∶ More than 17.7MΩ·μF	
		1000+48/-0 hours
Temperature	Capacitance change: within ±7.5%	1 cycle condition
Cycling	Tan δ, IR : initial spec.	Min. operating temperature → 25 °C
		$ ightarrow$ Max. operating temperature $ ightarrow$ 25 $^{\circ}$ C
		5 cycles test

## C. Recommended Soldering method :

Reflow ( Reflow Peak Temperature : 260+0/-5 $^{\circ}$ C, 10sec. Max )

<sup>\*</sup> For the more detail Specification, Please refer to the Samsung MLCC catalogue.